

# **GP400DDS18**

# **Dual Switch IGBT Module**

**Preliminary Information** 

DS5359-2.0 January 2001

#### **FEATURES**

- Non Punch Through Silicon
- Isolated Copper Baseplate
- Low Inductance Internal Construction

# **APPLICATIONS**

- High Power Inverters
- Motor Controllers
- Induction Heating
- Resonant Converters

The Powerline range of high power modules includes dual and single switch configurations covering voltages from 600V to 3300V and currents up to 4800A.

The GP400DDS18 is a dual switch 1800V, n channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) ensuring reliability in demanding applications.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise earthed heat sinks for safety.

### ORDERING INFORMATION

Order As:

### **GP400DDS18**

Note: When ordering, please use the whole part number.

#### **KEY PARAMETERS**

| V <sub>CES</sub>     |       | 1800V |
|----------------------|-------|-------|
| V <sub>CE(sat)</sub> | (typ) | 3.5V  |
| I <sub>C</sub>       | (max) | 400A  |
| I <sub>C(PK)</sub>   | (max) | 1600A |

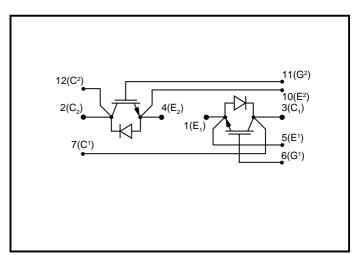


Fig. 1 Dual switch circuit diagram

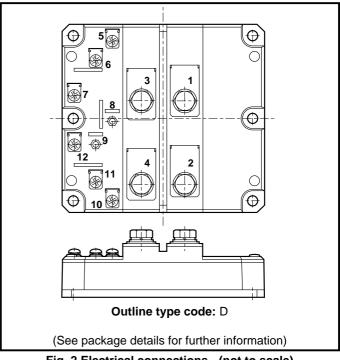


Fig. 2 Electrical connections - (not to scale)



# **ABSOLUTE MAXIMUM RATINGS - PER ARM**

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T<sub>case</sub> = 25°C unless stated otherwise

| Symbol             | Parameter                         | Test Conditions                                       |      | Units |
|--------------------|-----------------------------------|---|------|-------|
| V <sub>CES</sub>   | Collector-emitter voltage         | $V_{GE} = 0V$   | 1800 | V     |
| V <sub>GES</sub>   | Gate-emitter voltage              | -   | ±20  | V     |
| I <sub>c</sub>     | Continuous collector current      | $T_{case} = 65^{\circ}C$                              | 400  | А     |
| I <sub>C(PK)</sub> | Peak collector current            | 1ms, T <sub>case</sub> = 105°C                        | 800  | Α     |
| P <sub>max</sub>   | Max. transistor power dissipation | $T_{case} = 25^{\circ}C, T_{j} = 150^{\circ}C$        | 3000 | W     |
| V <sub>isol</sub>  | Isolation voltage                 | Commoned terminals to base plate. AC RMS, 1 min, 50Hz | 4000 | V     |

# THERMAL AND MECHANICAL RATINGS

| Symbol               | Parameter  | Test Conditions             | Min. | Max. | Units |
|----------------------|--|-----------------------------|------|------|-------|
| R <sub>th(j-c)</sub> | Thermal resistance - transistor (per arm)          | Continuous dissipation -    | -    | 42   | °C/kW |
|                      |  | junction to case            |      |      |       |
| R <sub>th(j-c)</sub> | Thermal resistance - diode (per arm)               | Continuous dissipation -    | -    | 80   | °C/kW |
|                      |  | junction to case            |      |      |       |
| R <sub>th(c-h)</sub> | Thermal resistance - case to heatsink (per module) | Mounting torque 5Nm         | -    | 8    | °C/kW |
|                      |  | (with mounting grease)      |      |      |       |
| T <sub>j</sub>       | Junction temperature                               | Transistor                  | -    | 150  | °C    |
|                      |  | Diode                       | -    | 125  | °C    |
| T <sub>stg</sub>     | Storage temperature range                          | -                           | -40  | 125  | °C    |
| -                    | Screw torque                                       | Mounting - M6               | -    | 5    | Nm    |
|                      |  | Electrical connections - M4 | -    | 2    | Nm    |
|                      |  | Electrical connections - M8 | -    | 10   | Nm    |



# **ELECTRICAL CHARACTERISTICS**

T<sub>case</sub> = 25°C unless stated otherwise.

| Symbol               | Parameter                            | Test Conditions  | Min. | Тур. | Max. | Units |
|----------------------|--------------------------------------|--|------|------|------|-------|
| I <sub>CES</sub>     | Collector cut-off current            | $V_{GE} = 0V$ , $V_{CE} = V_{CES}$   | -    | -    | 1    | mA    |
|                      |                                      | V <sub>GE</sub> = 0V, V <sub>CE</sub> = V <sub>CES</sub> , T <sub>case</sub> = 125°C | -    | -    | 12   | mA    |
| I <sub>GES</sub>     | Gate leakage current                 | $V_{GE} = \pm 20V, V_{CE} = 0V$  | -    | -    | 2    | μА    |
| V <sub>GE(TH)</sub>  | Gate threshold voltage               | $I_{\rm C}$ = 20mA, $V_{\rm GE}$ = $V_{\rm CE}$                                      | 4.5  | 5.5  | 6.5  | V     |
| V <sub>CE(sat)</sub> | Collector-emitter saturation voltage | V <sub>GE</sub> = 15V, I <sub>C</sub> = 400A   | -    | 3.5  | 4    | V     |
|                      |                                      | $V_{GE} = 15V, I_{C} = 400A, T_{case} = 125^{\circ}C$                                | -    | 4.3  | 5    | V     |
| I <sub>F</sub>       | Diode forward current                | DC   | -    | 400  | -    | А     |
| I <sub>FM</sub>      | Diode maximum forward current        | t <sub>p</sub> = 1ms   | -    | 800  | -    | Α     |
| V <sub>F</sub>       | Diode forward voltage                | I <sub>F</sub> = 400A  | -    | 2.2  | 2.5  | V     |
|                      |                                      | I <sub>F</sub> = 400A, T <sub>case</sub> = 125°C                                     | -    | 2.3  | 2.6  | V     |
| C <sub>ies</sub>     | Input capacitance                    | V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz                                | -    | 45   | -    | nF    |
| L <sub>M</sub>       | Module inductance                    | -  | -    | 20   | -    | nΗ    |



# **ELECTRICAL CHARACTERISTICS**

# T<sub>case</sub> = 25°C unless stated otherwise

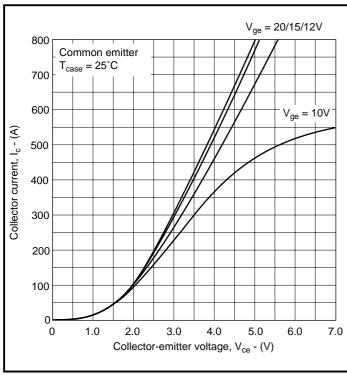
| Symbol             | Parameter                     | Test Conditions                      | Min. | Тур. | Max. | Units |
|--------------------|-------------------------------|--------------------------------------|------|------|------|-------|
| $t_{d(off)}$       | Turn-off delay time           | I <sub>c</sub> = 400A                | -    | 900  | 1100 | ns    |
| t <sub>f</sub>     | Fall time                     | $V_{GE} = \pm 15V$                   | -    | 280  | 350  | ns    |
| E <sub>OFF</sub>   | Turn-off energy loss          | V <sub>CE</sub> = 900V               | -    | 80   | 100  | mJ    |
| t <sub>d(on)</sub> | Turn-on delay time            | $R_{G(ON)} = R_{G(OFF)} = 2.2\Omega$ | -    | 500  | 650  | ns    |
| t <sub>r</sub>     | Rise time                     | L ~ 100nH                            | -    | 200  | 400  | ns    |
| E <sub>on</sub>    | Turn-on energy loss           |                                      | -    | 140  | 180  | mJ    |
| Q <sub>rr</sub>    | Diode reverse recovery charge | $I_F = 400A, V_R = 50\% V_{CES},$    | -    | 80   | 100  | μС    |
| I <sub>rr</sub>    | Diode reverse current         | dl <sub>F</sub> /dt = 3000A/μs       | -    | 250  | -    | А     |
| E <sub>REC</sub>   | Diode reverse recovery energy |                                      | -    | 70   | -    | mJ    |

# T<sub>case</sub> = 125°C unless stated otherwise

| Symbol              | Parameter                     | Test Conditions                      | Min. | Тур. | Max. | Units |
|---------------------|-------------------------------|--------------------------------------|------|------|------|-------|
| t <sub>d(off)</sub> | Turn-off delay time           | I <sub>c</sub> = 400A                | -    | 1010 | 1200 | ns    |
| t <sub>f</sub>      | Fall time                     | $V_{GE} = \pm 15V$                   | -    | 390  | 500  | ns    |
| E <sub>OFF</sub>    | Turn-off energy loss          | V <sub>CE</sub> = 900V               | -    | 100  | 150  | mJ    |
| t <sub>d(on)</sub>  | Turn-on delay time            | $R_{G(ON)} = R_{G(OFF)} = 2.2\Omega$ | -    | 660  | 800  | ns    |
| t <sub>r</sub>      | Rise time                     | L ~ 100nH                            | -    | 310  | 400  | ns    |
| E <sub>on</sub>     | Turn-on energy loss           |                                      | -    | 200  | 270  | mJ    |
| Q <sub>rr</sub>     | Diode reverse recovery charge | $I_F = 400A, V_R = 50\% V_{CES},$    | -    | 110  | 150  | μС    |
| l <sub>m</sub>      | Diode reverse current         | dl <sub>F</sub> /dt = 2500A/μs       | -    | 300  | -    | А     |
| E <sub>rec</sub>    | Diode reverse recovery energy |                                      | -    | 70   | -    | mJ    |



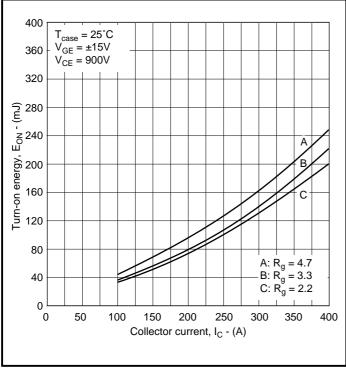
### **TYPICAL CHARACTERISTICS**



 $V_{ge} = 20/15/12V$ 800 Common emitter  $T_{case} = 125^{\circ}C$ 700 600  $V_{ge} = 10V$ Collector current, I<sub>C</sub> - (A) 500 400 300 200 100 0 5.0 7.0 1.0 2.0 3.0 4.0 6.0 8.0 9.0 10.0 0 Collector-emitter voltage,  $V_{ce}$  - (V)

Fig. 3 Typical output characteristics

Fig. 4 Typical output characteristics





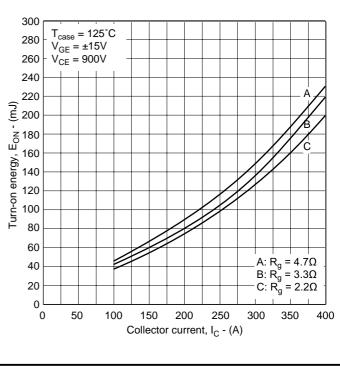
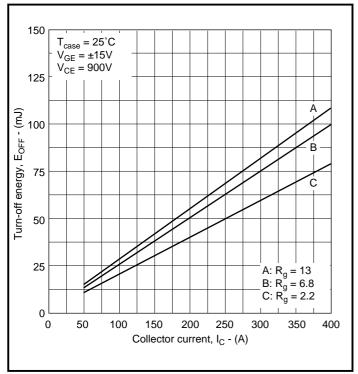


Fig. 6 Typical turn-off energy vs collector current





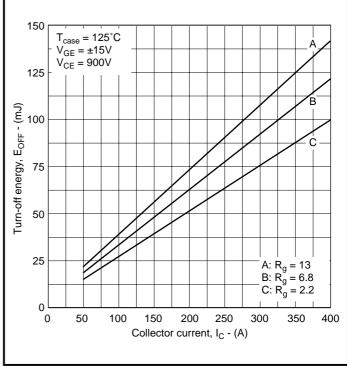
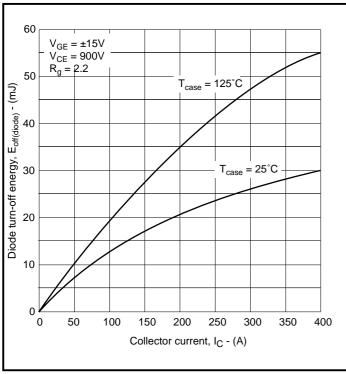
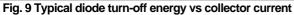


Fig. 7 Typical turn-off energy vs collector current

Fig. 8 Typical turn-off energy vs collector current





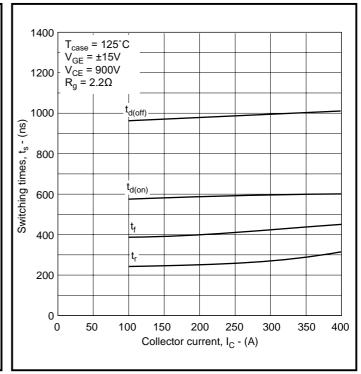
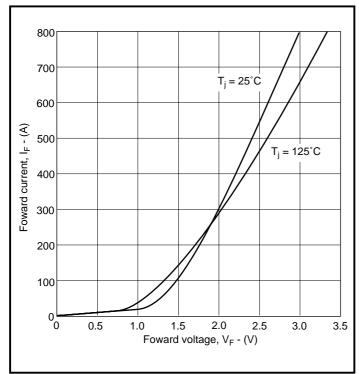


Fig. 10 Typical switching times

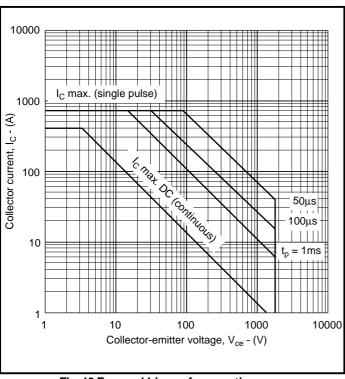


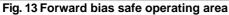


1000 900 800 700 Collector current, I<sub>C</sub> - (A) 600 500 400 300 T<sub>case</sub> = 125°C 200  $V_{ge} = \pm 15V$  $R_{g(min)} = 4.3\Omega$ 100  $\boldsymbol{R}_{g(min)}$  : Minimum recommended value 0 P 400 800 1200 1600 2000 Collector-emitter voltage, V<sub>ce</sub> - (V)

Fig. 11 Diode typical forward characteristics

Fig. 12 Reverse bias safe operating area





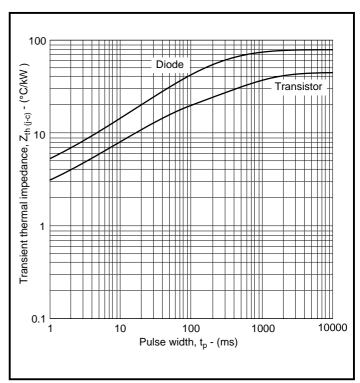
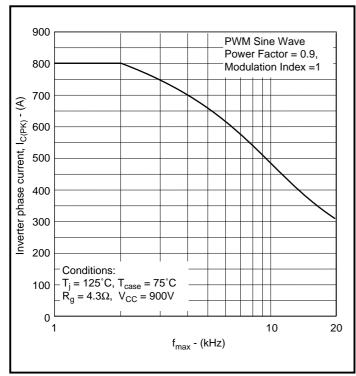


Fig.14 Transient thermal impedance





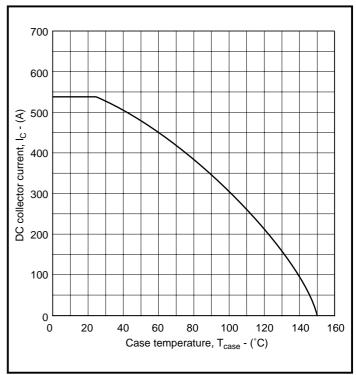


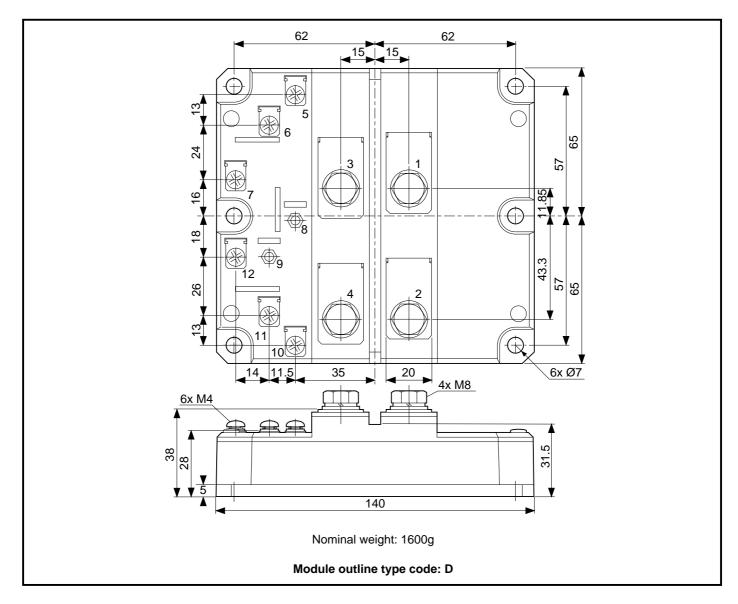
Fig.15 3-Phase inverter operating frequency

Fig.16 DC current rating vs case temperature



# **PACKAGE DETAILS**

For further package information, please visit our website or contact your nearest Customer Service Centre. All dimensions in mm, unless stated otherwise. DO NOT SCALE.





### **ASSOCIATED PUBLICATIONS**

| Title  | Application Note |  |
|--|------------------|--|
|  | Number           |  |
| Electrostatic handling precautions   | AN4502           |  |
| An introduction to IGBTs   | AN4503           |  |
| IGBT ratings and characteristics   | AN4504           |  |
| Heatsink requirements for IGBT modules   | AN4505           |  |
| Calculating the junction temperature of power semiconductors                     | AN4506           |  |
| Gate drive considerations to maximise IGBT efficiency                            | AN4507           |  |
| Parallel operation of IGBTs – punch through vs non-punch through characteristics | AN4508           |  |
| Guidance notes for formulating technical enquiries                               | AN4869           |  |
| Principle of rating parallel connected IGBT modules                              | AN5000           |  |
| Short circuit withstand capability in IGBTs                                      | AN5167           |  |
| Driving high power IGBTs with Concept gate drivers                               | AN5190           |  |

### **POWER ASSEMBLY CAPABILITY**

The Power Assembly group provides support for those customers requiring more than the basic semiconductor switch. Using CAD design tools the group has developed a flexible range of heatsink / clamping systems in line with advances in device types and the voltage and current capability of Dynex semiconductors.

An extensive range of air and liquid cooled assemblies is available covering the range of circuit designs in general use today.

### **HEATSINKS**

The Power Assembly group has a proprietary range of extruded aluminium heatsinks. These were designed to optimise the performance of Dynex semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

For further information on device clamps, heatsinks and assemblies, please contact your nearest sales representative or customer service office.





#### http://www.dynexsemi.com

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Preliminary Information: The product is in design and development. The datasheet represents the product as it is understood but details may change.

Advance Information: The product design is complete and final characterisation for volume production is well in hand.

No Annotation: The product parameters are fixed and the product is available to datasheet specification.

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Caution: This device is sensitive to electrostatic discharge. Users should follow ESD handling procedures.